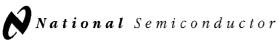
December 1994



### 54F/74F02 **Quad 2-Input NOR Gate**

#### **General Description**

This device contains four independent gates, each of which performs the logic NOR function.

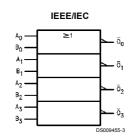
#### Ordering Code: See Section 0

Commercial	Military	Package Number	Package Description				
74F02PC		N14A	14-Lead (0.300" Wide) Molded Dual-In-Line				
	54F02DM (Note 2)	J14A	14-Lead Ceramic Dual-In-Line				
74F02SC (Note 1)		M14A	14-Lead (0.150" Wide) Molded Small Outline, JEDEC				
74F02SJ (Note 1)		M14D	14-Lead (0.300" Wide) Molded Small Outline, EIAJ				
	54F02FM (Note 2)	W14B	14-Lead Cerpack				
	54F02LM (Note 2)	E20A	20-Lead Ceramic Leadless Chip Carrier, Type C				

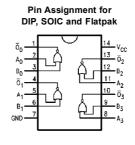
Note 1: Devices also available in 13" reel. Use suffix = SCX and SJX.

Note 2: Military grade device with environmental and burn-in processing. Use suffix = DMQB, FMQB and LMQB.

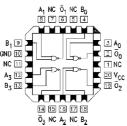
#### **Logic Symbol**



#### **Connection Diagrams**



Pin Assignment for LCC



DS009455-2

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# Unit Loading/Fan Out See Section 0 for U.L. definitions

		54F/74F				
Pin Names	Description	U.L.	Input I <sub>IH</sub> /I <sub>IL</sub>			
		HIGH/LOW	Output I <sub>OH</sub> /I <sub>OL</sub>			
A <sub>n</sub> , B <sub>n</sub>	Inputs	1.0/1.0	20 μA/-0.6 mA			
$\overline{O}_n$	Outputs	50/33.3	−1 mA/20 mA			

#### Absolute Maximum Ratings (Note 3)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature -65°C to +150°C

Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +175°C

Plastic -55°C to +150°C

 $V_{\rm CC}$  Pin Potential to

Ground Pin -0.5V to +7.0V Input Voltage (Note 4) -0.5V to +7.0V Input Current (Note 4) -30 mA to +5.0 mA

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

 $\begin{array}{lll} \mbox{Standard Output} & -0.5 \mbox{V to V}_{\rm CC} \\ \mbox{TRI-STATE} \mbox{\scriptsize @ Output} & -0.5 \mbox{\scriptsize V to } +5.5 \mbox{\scriptsize V} \end{array}$ 

Current Applied to Output

in LOW State (Max)  $\qquad \qquad \text{twice the rated I}_{\text{OL}} \, (\text{mA})$ 

## Recommended Operating Conditions

Free Air Ambient Temperature

Supply Voltage

Military +4.5V to +5.5V Commercial +4.5V to +5.5V

**Note 3:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 4: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

Symbol	I Parameter		54F/74F			Units	V <sub>cc</sub>	Conditions	
			Min	Тур	Max				
V <sub>IH</sub>	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal		
V <sub>IL</sub>	Input LOW Voltage			0.8	V		Recognized as a LOW Signal		
V <sub>CD</sub>	Input Clamp Diode			-1.2	V	Min	I <sub>IN</sub> = -18 mA		
V <sub>OH</sub>	Output HIGH 54F 10% V <sub>CC</sub>		2.5					I <sub>OH</sub> = -1 mA	
	Voltage	74F 10% $V_{\rm CC}$	2.5			V	Min	I <sub>OH</sub> = -1 mA	
		74F 5% $V_{\rm CC}$	2.7					I <sub>OH</sub> = -1 mA	
V <sub>OL</sub>	Output LOW	54F 10% V <sub>CC</sub>			0.5	V	Min	I <sub>OL</sub> = 20 mA	
	Voltage	74F 10% V <sub>CC</sub>			0.5			I <sub>OL</sub> = 20 mA	
I <sub>IH</sub>	Input HIGH	54F			20.0	μA	Max	V <sub>IN</sub> = 2.7V	
	Current	74F			5.0				
I <sub>BVI</sub>	Input HIGH	54F			100	μA	Max	V <sub>IN</sub> = 7.0V	
	Current					μ, ,	····	VIIN 1.50	
	Breakdown Test	74F			7.0				
I <sub>CEX</sub>	Output HIGH	54F			250	μA	Max	V <sub>OUT</sub> = V <sub>CC</sub>	
	Leakage Current	74F			50				
V <sub>ID</sub>	Input Leakage	74F	4.75			V	0.0	I <sub>ID</sub> = 1.9 μA	
	Test							All other pins grounded	
I <sub>OD</sub>	Output Leakage	74F			3.75	μA	0.0	V <sub>IOD</sub> = 150 mV	
	Circuit Current							All other pins grounded	
I <sub>IL</sub>	Input LOW Current				-0.6	mA	Max	V <sub>IN</sub> = 0.5V	
Ios	Output Short-Circuit Current		-60		-150	mA	Max	V <sub>OUT</sub> = 0V	
I <sub>CCH</sub>	Power Supply Current			3.7	5.6	mA	Max	V <sub>O</sub> = HIGH	
I <sub>CCL</sub>	Power Supply Current			8.7	13.0	mA	Max	V <sub>O</sub> = LOW	

#### **AC Electrical Characteristics**

See Section 0 for Waveforms and Load Configurations

	Parameter	74F			54F		74F		Units	
		T <sub>A</sub> = +25°C			T <sub>A</sub> , V <sub>CC</sub> = Mil C <sub>L</sub> = 50 pF		T <sub>A</sub> , V <sub>CC</sub> = Com C <sub>L</sub> = 50 pF			Fig.
Symbol		V <sub>CC</sub> = +5.0V C <sub>L</sub> = 50 pF		No.						
		Min	Тур	Max	Min	Max	Min	Max		
t <sub>PLH</sub>	Propagation Delay	2.5	4.4	5.5	2.5	7.5	2.5	6.5	no	++-++
t <sub>PHL</sub>	$A_n$ , $B_n$ to $\overline{O}_n$	1.5	3.2	4.3	1.5	6.5	1.5	5.3	ns	

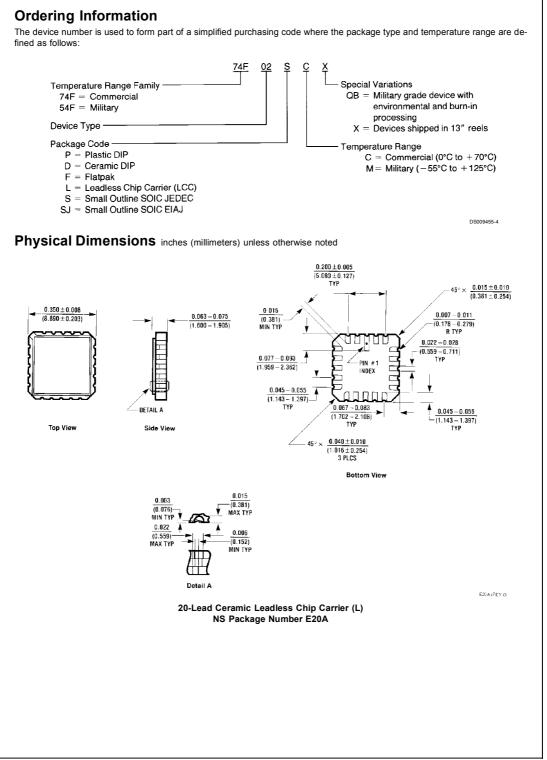
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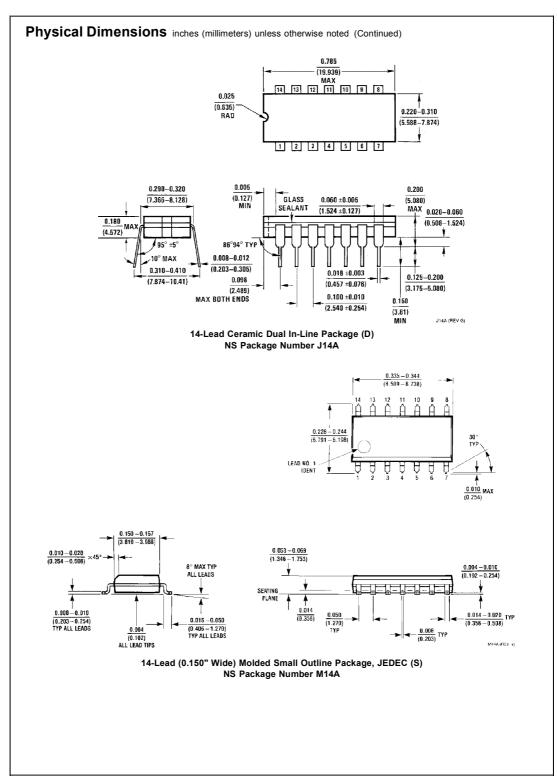
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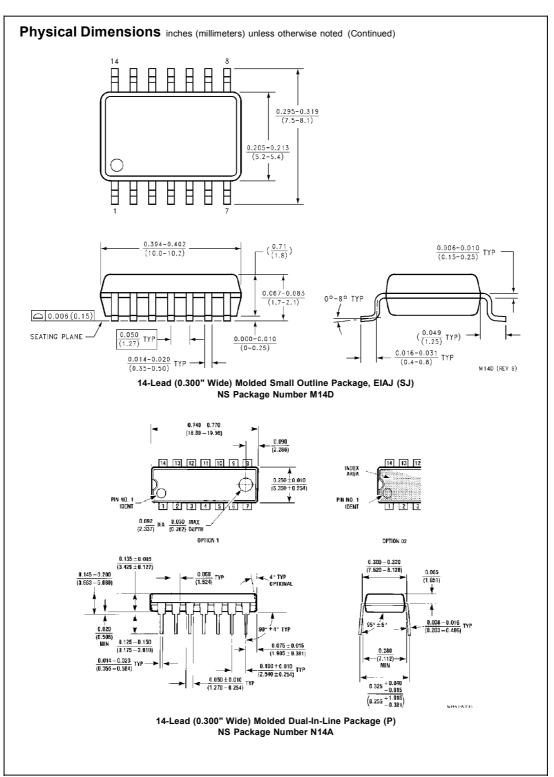




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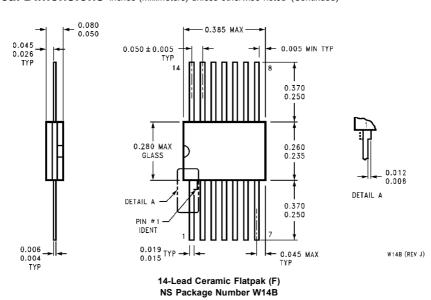
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#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



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